Product data sheet

1. General description

Ultrafast power diode in a SOT186A plastic package.

2. Features and benefit

- · Low forward voltage drop
- Low leakage current
- · Soft reverse recovery characteristics
- · High thermal cycling performance

3. Applications

- Home appliance power supply
- Discontinuous Current Mode (DCM) Power Factor Correction (PFC)

4. Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions		Va	lues		Unit
Absolute	maximum rating						
V_{RRM}	repetitive peak reverse voltage			6	00		V
$I_{O(AV)}$	average output current	δ = 0.5 ; square-wave pulse; $T_h \le 65$ °C; both diodes conducting; Fig. 1; Fig. 2; Fig. 3	20				A
I _{FRM}	repetitive peak forward current	δ = 0.5 ; t_p = 25 µs; $T_h \le$ 97 °C; square-wave pulse ; per diode	20				А
I _{FSM}	non-repetitive peak forward current	t_p = 10 ms; $T_{j(init)}$ = 25 °C; sine-wave pulse; per diode; Fig. 4	120		А		
		t_p = 8.3 ms; $T_{j(init)}$ = 25 °C; sine-wave pulse; per diode	132			А	
Symbol	Parameter	Conditions		Min	Тур	Max	Unit
Static ch	aracteristics						
V _F	forward voltage	I _F = 10 A; T _j = 25 °C; per diode; <u>Fig. 6</u>		-	1.3	1.7	V
		I _F = 10 A; T _j = 150 °C; per diode; <u>Fig. 6</u>		-	1.0	1.35	V
Dynamic	characteristics						
t _{rr}	reverse recovery time	$I_F = 1 \text{ A}; V_R = 30 \text{ V}; dI_F/dt = 100 \text{ A/}\mu\text{s};$ $T_j = 25 \text{ °C}; \text{ per diode}; Fig. 7$		-	30	50	ns

5. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outlin	Graphic symbol
1	А	anode	mb	A1 A2
2	K	cathode		
3	А	anode		K sym125
mb	n.c.	mounting base; isolated		
			1 2 3	

6. Ordering information

Table 3. Ordering information

Type number	Package	Package						
	Name	Description	Version					
BYV410X-600P	TO-220F	plastic single-ended package; isolated heatsink mounted; 1 mounting hole; 3-lead TO-220 "full pack"	SOT186A					

7. Marking

Table 4. Marking codes

Type number	Marking codes
BYV410X-600P	BYV410X-600P

8. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Values	Unit
V_{RRM}	repetitive peak reverse voltage		600	V
V_{RWM}	crest working reverse voltage		600	V
V_R	reverse voltage	DC	600	V
I _{O(AV)}	average output current	δ = 0.5; square-wave pulse; $T_h \le 65$ °C; both diodes conducting; Fig. 1; Fig. 2; Fig. 3	20	А
I _{FRM}	repetitive peak forward current	$δ = 0.5$; $t_p = 25 \mu s$; $T_h \le 97 °C$; square-wave pulse; per diode	20	А
I _{FSM}	non-repetitive peak forward current	t_p = 10 ms; $T_{j(init)}$ = 25 °C; sine-wave pulse; per diode; Fig. 4	120	А
		t_p = 8.3 ms; $T_{j(init)}$ = 25 °C; sine-wave pulse; per diode	132	А
T _{stg}	storage temperature		-55 to 175	°C
T _j	junction temperature		175	°C

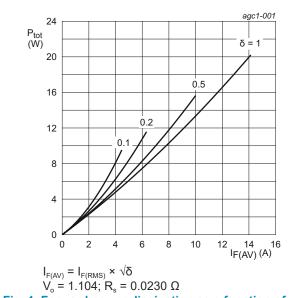
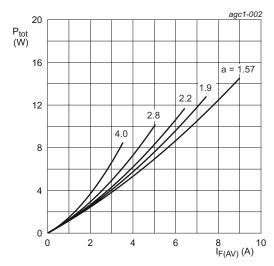


Fig. 1. Forward power dissipation as a function of average forward current; square waveform; maximum values; per diode



a = form factor = $I_{\text{F(RMS)}}/I_{\text{F(AV)}}$ Vo = 1.104 V; Rs = 0.0230 Ω

Fig. 2. Forward power dissipation as a function of average forward current; sinusoidal waveform; maximum values; per diode

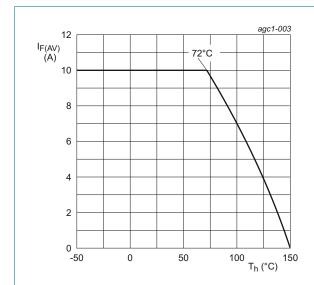


Fig. 3. Forward current as a function of heatsink temperature; maximum values; per diode

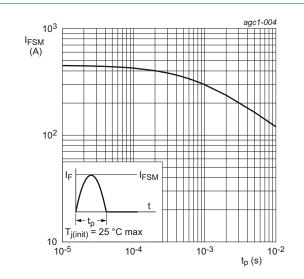
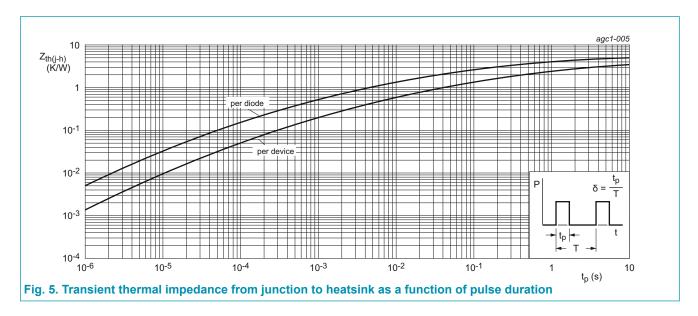


Fig. 4. Non-repetitive peak forward current as a function of pulse width; sinusoidal waveform; maximum values; per diode

9. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-h)}$	thermal resistance	per diode; <u>Fig. 5</u>	-	-	5	K/W
from junction to heatsink	both diodes conducting; Fig. 5	-	-	3.5	K/W	
R _{th(j-a)}	thermal resistance from junction to ambient free air	in free air	-	60	-	K/W



10. Isolation characteristics

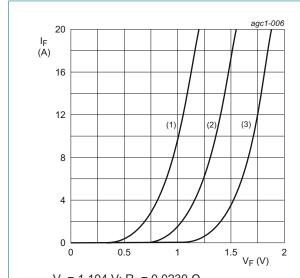
Table 7. Isolation characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V _{isol(RMS)}	RMS isolation voltage	50 Hz ≤ f ≤ 60 Hz; RH ≤ 65 %; from all pins to external heatsink; sinusoidal waveform; clean and dust free	-	-	2500	V
C _{isol}	isolation capacitance	from cathode to external heatsink	-	10	-	PF

11. Characteristics

Table 8. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	aracteristics					
V _F	forward current	I _F = 10 A; T _j = 25 °C; per diode; <u>Fig. 6</u>	-	1.3	1.7	V
		I _F = 10 A; T _j = 150 °C; per diode; <u>Fig. 6</u>	-	1.0	1.35	V
		I _F = 16 A; T _j = 25 °C; per diode; <u>Fig. 6</u>	-	1.35	1.75	V
		I _F = 16 A; T _j = 150 °C; per diode; <u>Fig. 6</u>	-	1.1	1.45	V
I _R	reverse current	V _R = 600 V; T _j = 25 °C; per diode	-	1	10	μΑ
		V _R = 600 V; T _j = 150 °C; per diode	-	0.1	0.5	mA
Dynamic	characteristics					
Q _r	reverse charge	$I_F = 1 \text{ A}; V_R = 30 \text{ V}; dI_F/dt = 100 \text{ A}/\mu\text{s};$ $T_j = 25 \text{ °C}; \text{ per diode}; Fig. 7$	-	22	-	nC
t _{rr}	reverse recovery time	$I_F = 1 \text{ A}; V_R = 30 \text{ V}; dI_F/dt = 100 \text{ A}/\mu\text{s};$ $T_j = 25 \text{ °C}; \text{ per diode}; Fig. 7$	-	30	50	ns
		$I_F = 1 \text{ A}; V_R = 30 \text{ V}; dI_F/dt = 50 \text{ A}/\mu\text{s};$ $T_j = 25 \text{ °C}; \text{ per diode}; Fig. 7$	-	40	55	ns
		$I_F = 0.5 \text{ A}; I_{rr} = 0.25 \text{ A}; I_R = 1 \text{ A};$ $T_j = 25 ^{\circ}\text{C}; \text{ per diode}; Fig. 7$	-	-	35	ns
I _{RM}	peak reverse recovery current	$I_F = 1 \text{ A}; V_R = 30 \text{ V}; dI_F/dt = 100 \text{ A}/\mu\text{s};$ $T_j = 25 \text{ °C}; \text{ per diode}; Fig. 7$	-	1.6	-	А
		$I_F = 1 \text{ A}; V_R = 30 \text{ V}; dI_F/dt = 50 \text{ A}/\mu\text{s};$ $T_j = 25 \text{ °C}; \text{ per diode}; \underline{\text{Fig. 7}}$	-	1.1	-	А
E _{as}	non-repetitive avalanche energy	I _R = 4.8 A; T _{j(init)} = 25 °C; L = 15 mH	130	175	-	mJ



 V_o = 1.104 V; R_s = 0.0230 Ω (1) T_j = 150 °C; typical values (2) T_j = 150 °C; maximum values (3) $T_j = 25$ °C; maximum values

Fig. 6. Forward current as a function of forward voltage; per diode

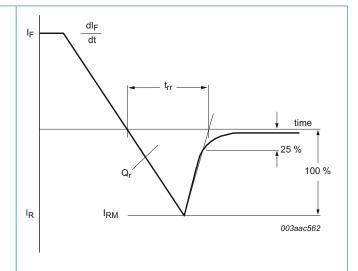
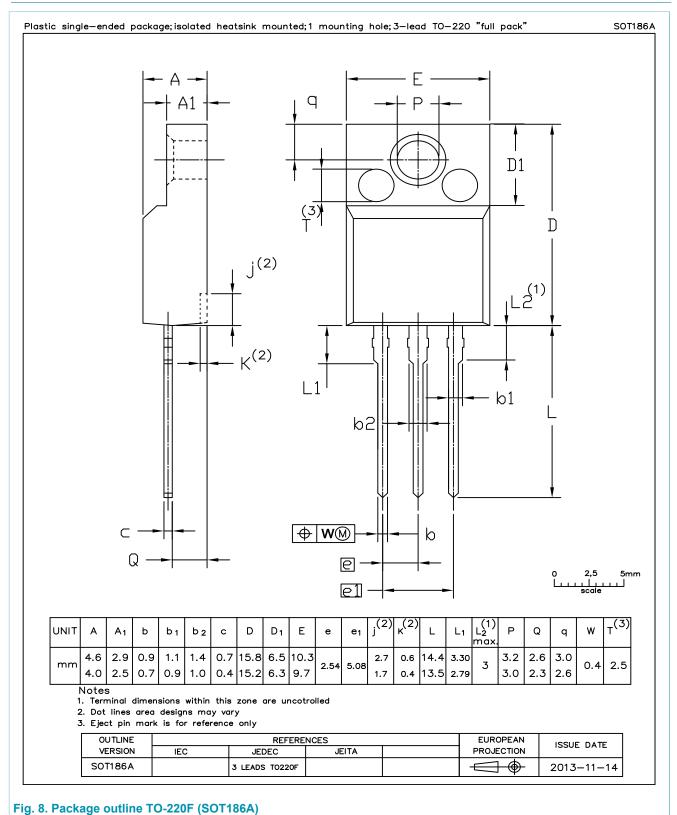


Fig. 7. Reverse recovery definitions; ramp recover

12. Package outline



BYV410X-600P

13. Legal information

Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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Product [short] data sheet	Production	This document contains the product specification.

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